



FORM PTO-1449

U.S. DEPARTMENT OF COMMERCE PATENT &amp; TRADEMARK OFFICE

SHEET 1 OF 2  
(REV. 7-80)**LIST OF REFERENCES CITED BY APPLICANT**

(Use Several Sheets if Necessary)

DOCKET NO.: 2830/1H701-US1

APPLICANT: Teresa J. Bandosz, et al.

SERIAL NO: 09/997,398

FILING DATE: November 29, 2001

CONFIRMATION NO: 2434

**U.S. PATENT DOCUMENTS**

<u>*EXAMINER INITIALS</u>	<u>DOCUMENT NUMBER</u>	<u>DATE</u>	<u>NAME</u>	<u>CLASS</u>	<u>SUBCLASS</u>	<u>FILING DATE</u>
SJA ↓	1. 3,619,420	11/9/71	Kemmer et al.	210	6	8/22/69
	2. 3,887,461	6/3/75	Nickerson et al.	210	39	4/16/73
	3. 3,998,756	12/21/76	Sutherland	252	422	6/17/74
	4. 4,122,036	10/24/78	Lewis	252	421	1/7/77
	5. 5,338,462	8/16/94	Abe et al.	210	757	6/15/93

**OTHER REFERENCES****(INCLUDING AUTHOR, TITLE DATE, PERTINENT PAGES, ETC.)****\*EXAMINER  
INITIALS**SJA  
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6. Piskorz, J.; Scott, D.S.; Westerberg, I.B. Flash pyrolysis of sewage sludge. Ind. Proc. Eng. Chem. Des. Dev., 1996, 25: 265-270.
7. Lu, G.Q. Preparation and Evaluation of Adsorbents from Waste Carbonaceous Materials for  $\text{SO}_x$  and  $\text{NO}_x$  Removal. Environmental Progress 1996, 15: 12.
8. Lu, G.Q.; Lau, D.D. Characterization of Sewage Sludge-Derived Adsorbents for  $\text{H}_2\text{S}$  Removal. Part 2: Surface and Pore Structural Evolution in Chemical Activation. Gas. Sep. Purif. 1996, 10: 103.
9. Chiang, P.C.; You, J.H. Use of Sewage Sludge for Manufacturing Adsorbents. Canadian J. Chem. Eng. 1987, 65: 922.

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APR 9 - 2002  
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**\*EXAMINER**  
**INITIALS***5/28*

10. Lu, G.Q.; Low, J.C.F.; Lui, C.Y.; Lua, A.C. Surface Area Development of Sewage Sludge During Pyrolysis. Fuel 1995, 74: 344.

EXAMINER: \_\_\_\_\_

*Nejlsan*

DATE CONSIDERED: \_\_\_\_\_

*2/3/02***\*EXAMINER:**

Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



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sup	1. 3,887,461	6/3/1975	Nickerson, et al.	210	39	4/16/73
	(Cited Previously on 4/2/02)					
sub	2. 6,030,922	2/29/2000	Khalili, et al.	502	424	7/10/1998

**FOREIGN PATENT DOCUMENTS**

<u>*EXAMINER INITIALS</u>	<u>DOCUMENT NUMBER</u>	<u>DATE</u>	<u>COUNTRY</u>	<u>CLASS</u>	<u>SUBCLASS</u>	<u>TRANSLATION YES NO</u>
sub	3. 1 385 453	2/26/1975	GREAT BRITAIN	C01B	31/08	X
	4. 41 02 557	7/30/1992	GERMANY	B01J	37/10	X
	5. 0 729 783	9/4/1996	EUROPE	B01J	20/20	X
	6. 2000-319011	11/21/2000	JAPAN	C01B	31/02	Abstract Only
	7. 11-057399	3/2/1999	JAPAN	B01D	53/56	Abstract Only

**OTHER REFERENCES****(INCLUDING AUTHOR, TITLE DATE, PERTINENT PAGES, ETC.)****\*EXAMINER  
INITIALS**

EXAMINER: \_\_\_\_\_

*Antickson*

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*2/3/04***\*EXAMINER:**

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